



Photoconductive and polarization properties of individual CdTe nanowires

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ABSTRACT

Metal-Cd_{0.42}Te_{0.58}-metal nanowires were electrodeposited into the pores of anodized aluminum oxide (AAO) membranes, and the polarization sensitive photoconductance was analyzed for individual nanostructures. Non-linear *I*-*V* curves were observed, and the short-circuit current density, open-circuit voltage, and fill factor were determined. These nanowires exhibited a power conversion efficiency of 0.56%, which is higher than some comparable nanomaterials of greater complexity.

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1. Introduction

Semiconducting nanowires are attractive materials for optoelectronics and, specifically, cadmium-chalcogenide nanowires have shown promise for future applications [1,2]. Specific types have proven to be useful device components due to their sensitivity to polarization [3], enhanced carrier mobilities [4], and photoconductive properties [5,6] and cadmium telluride is easily made p- or n-type by varying growth conditions during CVD synthesis [7].

Although previous research has demonstrated photoconductance in random mats [8], the photoconductivity of individual CdTe wires has not been investigated. CdTe is a photoconductive II-VI semiconductor with a high optical absorption coefficient [9,10] and a direct band gap in the visible range that makes it an ideal material for photovoltaics.

Previous studies [11,12] have fabricated semiconducting Cd-chalcogenide nanowires in porous AAO templates. Their investigations on electrical transport through CdS and CdSe nanowires focused on the effects of photoelectrically induced *I*-*V* changes and a coaxial SiO₂ gate dielectric, respectively. In this study the *I*-*V* relationships of individual metal-Cd_{0.42}Te_{0.58}-metal nanowires are investigated under various photon energy excitations. For individual wires we observed an increase in nanowire current as a function of impinged photon energy, as well as anisotropy in the response to photon polarization. The power conversion efficiency is determined, and information about the phases present in this material is also presented.

2. Experimental

An electrolyte previously employed by Wang et al. [13] was used to deposit wires into the pores of an AAO template with 200 nm pores (Whatman Anodisc 13), and Cd_{0.42}Te_{0.58} nanowires were fabricated electrochemically as described elsewhere [14–16]. After deposition the Ag working electrode was etched in HNO₃ and the template was dissolved in 1 M NaOH, followed by rinsing (5×) in ethanol. Compositional characterization was performed using an INCA Penta-FET energy dispersive spectroscopy system (EDS, Oxford Instruments) attached to a Hitachi S-4700 FE-SEM. Powder X-ray diffraction was performed using CuKα radiation.

Wires were drop cast onto prefabricated 15 μm gap gold microelectrodes on a p⁺Si:SiO₂ substrate [17]. The nanowires were then connected to the microelectrodes using a combination of electron and ion beam induced deposition of Pt between the gold segments of the nanowires and the microelectrodes using an FEI Helios 600 Nanolab Focused Ion Beam (FIB) [16,18]. Electrical measurements were performed in ambient conditions at room temperature with a Keithley 2400 sourcemeter. Photon sources were either a 5 mW unfocused laser diode or a 150 W halogen lamp.

The effect of photon energy *E*_{ph} on the *I*-*V* characteristic of individual nanowires was tested with Phillips Lumileds LEDs. Each LED was calibrated to emit 45 lumens. LEDs were turned on and off in succession while a constant potential was applied across the nanowire and the current was measured. Polarization experiments were performed using a high powered (150 W) broad spectrum halogen lamp connected to a fiber optic cable used to direct the light to the polarizer, then onto the nanowire. The polarizer was rotated 2° between each measurement through a range of 2π radians and the measured photoconductance revealed anisotropy (Fig. 4a).

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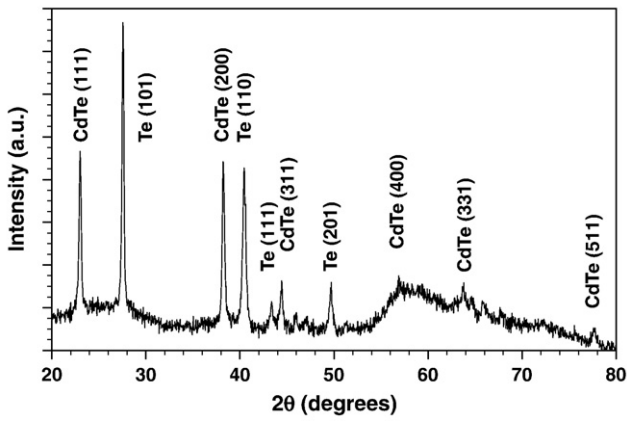


Fig. 1. Pure Te peaks are expected due to the as grown stoichiometry of these wires. Phase separation between Te clusters and the CdTe matrix has been previously explored by Lepiller et al. [19].

3. Results and discussion

X-ray diffraction data for the $Cd_{0.42}Te_{0.58}$ material shows that both CdTe and a small number of pure Te domains exist, likely because of the Te-rich status of the wires (Fig. 1) [19]. The templated electrodeposition technique for nanowire fabrication allows for facile control over various sections of wire length, as evidenced by the EDS data (Fig. 2). Clearly defined segments of the $Au-Cd_{0.42}Te_{0.58}-Au$ wires allowed $Cd_{0.42}Te_{0.58}$ segments to be electrically connected to macroscopic leads via contact with the Au wire ends, ensuring that $Cd_{0.42}Te_{0.58}$ sections were not altered or damaged during FIB deposition of Pt.

Each nanowire had a non-linear $I-V$ characteristic for a -10 V to 10 V sweep. Under illumination the conductance of the nanowire increased compared to measurements in ambient or dark conditions. Impinging laser light decreased the typical nanowire resistance from 42 ± 2 kΩ to 30 ± 2 kΩ (assessed at $V \sim eq - 7V$ in Fig. 2). Various LEDs ($E_{ph} = 2.69$ eV, 2.34 eV, 2.10 eV, 1.97 eV, peak width of 0.1 eV) were impinged on the wire while a constant potential was applied across the wire (Fig. 3). The 2.69 eV LED increased the conductivity of the nanowire most significantly, over twice as much as the 1.97 eV LED. For direct gap absorption,

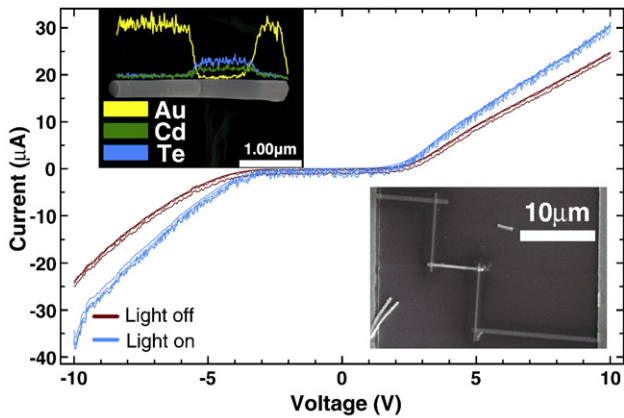


Fig. 2. Comparison between dark and illuminated (150 W halogen lamp) $I-V$ curves. Top inset: SEM image of a $Au-Cd_{0.42}Te_{0.58}-Au$ nanowire with EDS data indicating the multicomponent structure of the nanowires. Bottom inset: SEM image of a single $Au-Cd_{0.42}Te_{0.58}-Au$ nanowire connected to microelectrodes via Pt-deposited films [18].

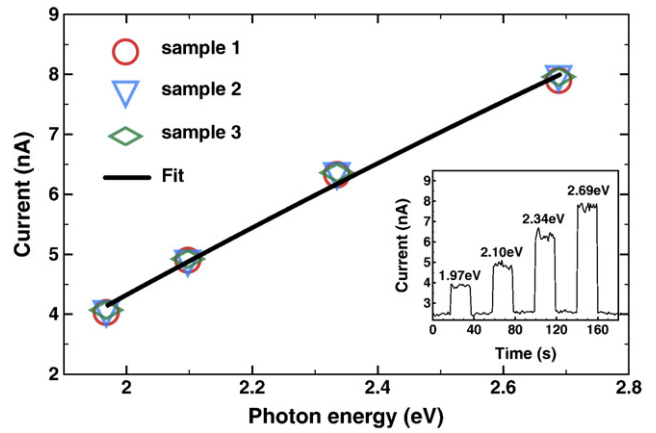


Fig. 3. Incident photon energy and corresponding currents for three different nanowire samples. $VSD = 1$ V. The data fit the equation $I = A(E_{ph} - E_g)^{3/2} / E_{ph}$ with $A = 1.15E - 8$ and $E_g = 1.17$ eV.

the data $I(E_{ph})$ can be fit to $\alpha = A(E_{ph} - E_g)^{3/2} / E_{ph}$, where α is the adsorption coefficient and E_g is the band gap, as expected for CdTe [20]. Fitting $I(E_{ph})$ to the excitation data (Fig. 3) resulted in a band gap of 1.17 eV, which is consistent with previous reports on Te-rich CdTe materials [19].

When the polarization was parallel to the nanowire the increase in current was maximized and minimized when it was perpendicular

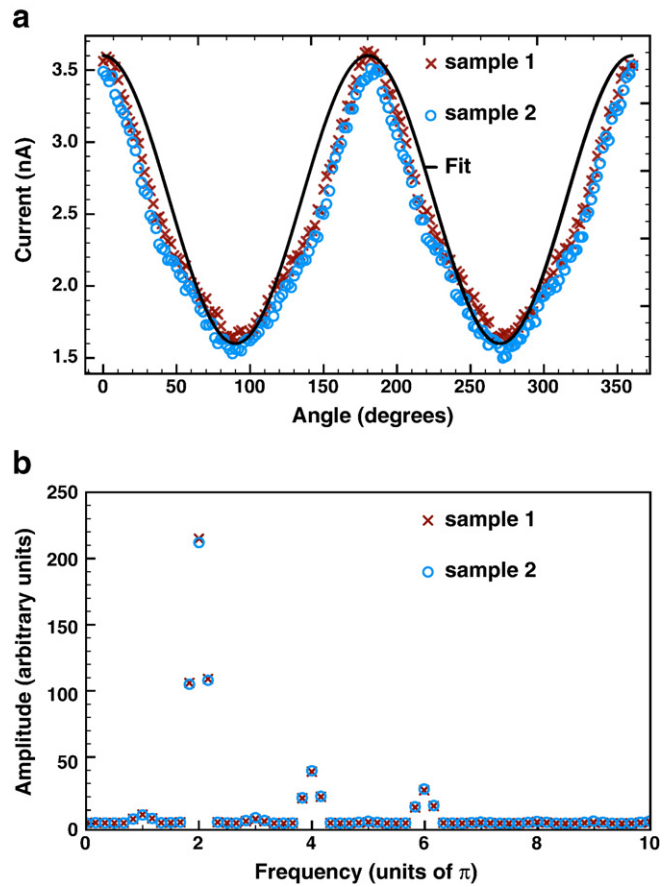


Fig. 4. (a) Polarization angle with respect to the long axis versus current through a single nanowire shows current maximization when polarization was parallel to the long axis of the nanowire with $VSD = 1$ V. (b) The Fourier Transform of (a). Note the harmonics at twice and three times the fundamental frequency. Data from two wires is represented.

(Fig. 4a). This agrees with the expected absorption by a cylinder of diameter $D \ll \lambda$ [21]. The polarization ratio, $\rho = (I_{\parallel} - I_{\perp}) / (I_{\parallel} + I_{\perp})$, of the intensities parallel (I_{\parallel}) and perpendicular (I_{\perp}) yields $\rho = 0.38 \pm 0.03$, which, when fitted to $\cos^2(\theta)$, yields $R^2 = 0.86$.

The Fourier transform (Fig. 4b) contained strong harmonics in addition to the fundamental oscillation. The harmonics contain approximately 25% of the spectral weight. We speculate that the extra harmonics might arise from misalignments in the polarizer, scattering from the metal leads, or the finite aspect ratio of the CdTe segment [21].

The short-circuit current density I_{sc} , open circuit voltage V_{oc} , along with maximum voltage V_{max} , and current max I_{max} between I_{sc} and V_{oc} were determined. Fill factor FF was used to calculate the energy conversion efficiency $\eta = (I_{max}V_{max}FF) / P_{in}$, where $FF = I_{max}V_{max} / I_{sc}V_{oc}$ (extracted from Fig. 2), I_{max} and V_{max} are the current and voltage maxima, respectively, and P_{in} is the incident power intensity [22]. $\eta = 5.6 \times 10^{-3} \pm 0.5 \times 10^{-3}$ was obtained; this value is somewhat higher than what has been previously reported for more complicated materials [23]. Further improvements in the conversion efficiency may be realized by improvements in the fill factor, which can be achieved by reducing the series resistance of the device through the creation of graded interfaces between the metal and semiconductor segments of the nanowire, as has been demonstrated [18].

4. Conclusions

Metal-Cd_{0.42}Te_{0.58}-metal nanowires were fabricated via sequential electrodeposition into the pores of AAO. These wires produced non-linear I - V curves and were photoconductive. Both photon energy and polarization angle modulated the amount of photoconductance in single wires. Higher photon energies caused an increase in conductivity of $\sim 2.5\times$. These measurements showed that there is strong potential for metal-CdTe-metal nanowires in photovoltaic applications.

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References

- [1] Agarwal R, Lieber CM. Appl Phys A 2006;85:209.
- [2] Duan X, Huang Y, Agarwal R, Lieber CM. Nature 2003;421:241.
- [3] Wang J, Gudiksen MS, Duan X, Cui Y, Lieber CM. Science 2001;293:1455.
- [4] Johnson JC, Knutson KP, Yan H, Law M, Yang P, Saykally RJ. Nano Lett 2003;4:197.
- [5] Huynh WU, Dittmer JJ, Alivisatos AP. Science 2002;295:2425.
- [6] Gur I, Fromer NA, Geier ML, Alivisatos AP. Science 2005;310:462.
- [7] Huang L, Zhao Y, Cai D. Mater Lett 2009;63:2082.
- [8] Yu Y, Protasenko V, Jena D, Xing H, Kuno M. Nano Lett 2008;8(5):1352.
- [9] Mitchell K, Fahrenbruch AL, Bube RH. Appl Phys Lett 1977;48:829.
- [10] Ma YY, Fahrenbruch AL, Bube RH. Appl Phys Lett 1977;30:423.
- [11] Pena DJ, Mbindyo JKN, Carado AJ, Mallouk TE, Keating CD, Razavi B, Mayer TS. J Phys Chem B 2002;106:7458.
- [12] Kovtyukhova N, Kelley B, Mallouk TE. J Am Chem Soc 2004;126:605.
- [13] Wang X, Ozkan C. Nano Lett 2008;8:398.
- [14] Sima M, Enculescu I, Trautman C, Neumann R. J Optoelectron Adv Mater 2004;6:121.
- [15] Kum MC, Yoo BY, Rheem YW, Bozhilov KN, Chen W, Mulchandani A, Myung NV. Nanotechnology 2008;19:325711.
- [16] Mair LO, Skinner K, Donley C, Superfine R. ECS Trans 2009;19:99.
- [17] Williams PA, Papadakis SJ, Patel AM, Falvo MR, Washburn S, Superfine R. Appl Phys Lett 2003;82:805.
- [18] Skinner K, Dwyer C, Washburn S. Appl Phys Lett 2008;92:112105.
- [19] Lepiller C, Lincot C. J Electrochem Soc 2004;151:C348.
- [20] Fan HY. Rep Prog Phys 1956;19:107.
- [21] van de Hulst HC, Light Scattering by Small Particles (Dover, 1981) 297ff.
- [22] Wei W, Bao X-Y, Soci C, Ding Y, Wang ZL, Wang D. Nano Lett 2009;9:2926.
- [23] Raska P, Nilphai S, Gardcharen A, Choopun S. Thin Solid Films 2009;517(17):4741.